

SN54ALS299, SN74ALS299 8-BIT UNIVERSAL SHIFT/STORAGE REGISTERS WITH 3-STATE OUTPUTS

SDAS220B – DECEMBER 1982 – REVISED DECEMBER 1994

- **Multiplexed I/O Ports Provide Improved Bit Density**
- **Four Modes of Operation:**
 - Hold (Store)
 - Shift Right
 - Shift Left
 - Load Data
- **Operate With Outputs Enabled or at High Impedance**
- **3-State Outputs Drive Bus Lines Directly**
- **Can Be Cascaded for n-Bit Word Lengths**
- **Direct Overriding Clear**
- **Applications:**
 - Stacked or Push-Down Registers
 - Buffer Storage
 - Accumulator Registers
- **Package Options Include Plastic Small-Outline (DW) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) 300-mil DIPs**

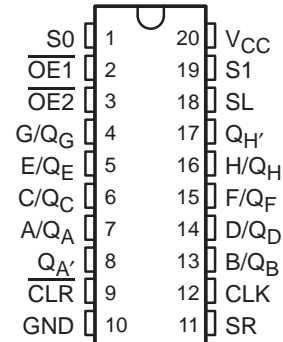
description

These 8-bit universal shift/storage registers feature multiplexed I/O ports to achieve full 8-bit data handling in a single 20-pin package. Two function-select (S_0 , S_1) inputs and two output-enable ($\overline{OE1}$, $\overline{OE2}$) inputs can be used to choose the modes of operation listed in the function table.

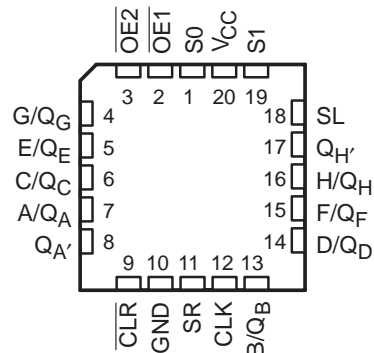
Synchronous parallel loading is accomplished by taking both S_0 and S_1 high. This places the 3-state outputs in the high-impedance state and permits data applied on the I/O ports to be clocked into the register. Reading out of the register can be accomplished while the outputs are enabled in any mode. Clearing occurs asynchronously when the clear (\overline{CLR}) input is low. Taking either $\overline{OE1}$ or $\overline{OE2}$ high disables the outputs, but has no effect on clearing, shifting, or storing data.

The SN54ALS299 is characterized for operation over the full military temperature range of -55°C to 125°C . The SN74ALS299 is characterized for operation from 0°C to 70°C .

SN54ALS299 . . . J PACKAGE
SN74ALS299 . . . DW OR N PACKAGE
(TOP VIEW)



SN54ALS299 . . . FK PACKAGE
(TOP VIEW)



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8-BIT UNIVERSAL SHIFT/STORAGE REGISTERS

WITH 3-STATE OUTPUTS

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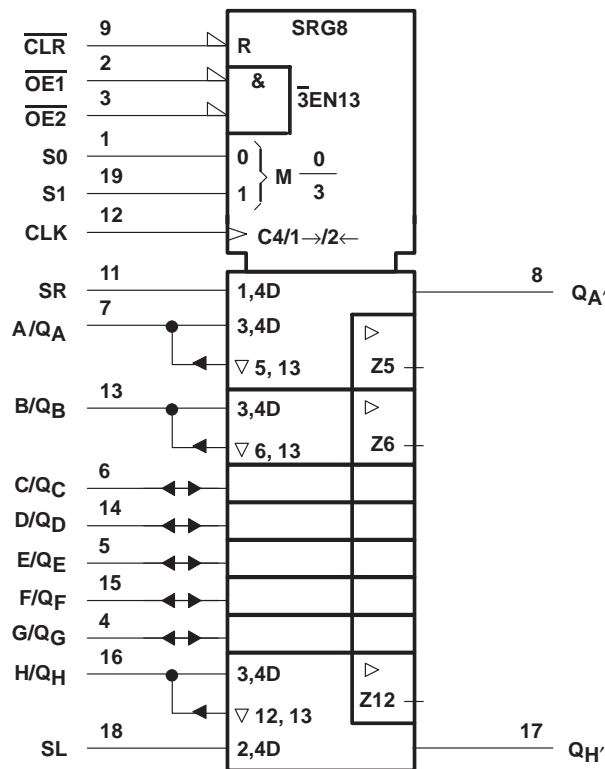
FUNCTION TABLE

MODE	INPUTS								I/O PORTS								OUTPUTS			
	$\overline{\text{CLR}}$	S1	S0	$\overline{\text{OE1}}^\dagger$	$\overline{\text{OE2}}^\dagger$	CLK	SL	SR	A/QA	B/QB	C/QC	D/QD	E/QE	F/QF	G/QG	H/QH	QA'	QH'		
Clear	L	X	L	L	L	X	X	X	L	L	L	L	L	L	L	L	L	L	L	L
	L	L	X	L	L	X	X	X	L	L	L	L	L	L	L	L	L	L	L	L
	L	H	H	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	L	L
Hold	H	L	L	L	L	X	X	X	QA0	QB0	QC0	QD0	QE0	QF0	QG0	QH0	QA0	QH0	QA0	QH0
	H	X	X	L	L	L	X	X	QA0	QB0	QC0	QD0	QE0	QF0	QG0	QH0	QA0	QH0	QA0	QH0
Shift Right	H	L	H	L	L	↑	X	H	H	QA _n	QB _n	QC _n	QD _n	QE _n	QF _n	QG _n	H	QH _n	H	QH _n
	H	L	H	L	L	↑	X	L	L	QA _n	QB _n	QC _n	QD _n	QE _n	QF _n	QG _n	L	QH _n	L	QH _n
Shift Left	H	H	L	L	L	↑	H	X	QB _n	QC _n	QD _n	QE _n	QF _n	QG _n	QH _n	H	QB _n	H	QB _n	H
	H	H	L	L	L	↑	L	X	QB _n	QC _n	QD _n	QE _n	QF _n	QG _n	QH _n	L	QB _n	L	QB _n	L
Load	H	H	H	X	X	↑	X	X	a	b	c	d	e	f	g	h	a	h	a	h

NOTE: a . . . h = the level of the steady-state input at inputs A through H, respectively. This data is loaded into the flip-flops while the flip-flop outputs are isolated from the I/O terminals.

† When one or both output-enable inputs are high, the eight I/O terminals are disabled to the high-impedance state; however, sequential operation or clearing of the register is not affected.

logic symbol†



† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

SN54ALS299, SN74ALS299

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SDAS220B – DECEMBER 1982 – REVISED DECEMBER 1994

recommended operating conditions

		SN54ALS299			SN74ALS299			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC}	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
V_{IH}	High-level input voltage	2			2			V
V_{IL}	Low-level input voltage			0.7			0.8	V
I_{OH}	High-level output current	Q_A' or Q_H'		-0.4			-0.4	mA
		$Q_A - Q_H$		-1			-2.6	
I_{OL}	Low-level output current	Q_A' or Q_H'		4			8	mA
		$Q_A - Q_H$		12			24	
T_A	Operating free-air temperature	-55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		SN54ALS299			SN74ALS299			UNIT
				MIN	TYP†	MAX	MIN	TYP†	MAX	
V_{IK}		$V_{CC} = 4.5\text{ V}$,	$I_I = -18\text{ mA}$			-1.5			-1.5	V
V_{OH}	All outputs	$V_{CC} = 4.5\text{ V to }5.5\text{ V}$,	$I_{OH} = -0.4\text{ mA}$	$V_{CC} - 2$		$V_{CC} - 2$				V
	$Q_A - Q_H$	$V_{CC} = 4.5\text{ V}$	$I_{OH} = -1\text{ mA}$	2.4	3.3			2.4	3.2	
V_{OL}	Q_A' or Q_H'	$V_{CC} = 4.5\text{ V}$	$I_{OL} = 4\text{ mA}$	0.25	0.4			0.25	0.4	V
			$I_{OL} = 8\text{ mA}$					0.35	0.5	
	$Q_A - Q_H$	$V_{CC} = 4.5\text{ V}$	$I_{OL} = 12\text{ mA}$	0.25	0.4			0.25	0.4	
			$I_{OL} = 24\text{ mA}$					0.35	0.5	
I_I	A - H	$V_{CC} = 5.5\text{ V}$	$V_I = 5.5\text{ V}$			0.1			0.1	mA
	Any others		$V_I = 7\text{ V}$			0.1			0.1	
I_{IH}^\ddagger		$V_{CC} = 5.5\text{ V}$,	$V_I = 2.7\text{ V}$			20			20	μA
I_{IL}^\ddagger	S0, S1, SR, SL	$V_{CC} = 5.5\text{ V}$,	$V_I = 0.4\text{ V}$			-0.2			-0.2	mA
	Any others					-0.1			-0.1	
I_{OS}^\S	Q_A' or Q_H'	$V_{CC} = 5.5\text{ V}$,	$V_O = 2.25\text{ V}$	-15		-70		-15		mA
	$Q_A - Q_H$			-20		-112		-30		
I_{CC}		$V_{CC} = 5.5\text{ V}$	Outputs high	15		28		15		mA
			Outputs low	22		38		22		
			Outputs disabled	23		40		23		

† All typical values are at $V_{CC} = 5\text{ V}$, $T_A = 25^\circ\text{C}$.

‡ For I/O ports ($Q_A - Q_H$), the parameters I_{IH} and I_{IL} include the off-state output current.

§ The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, I_{OS} .



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timing requirements over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

		SN54ALS299		SN74ALS299		UNIT	
		MIN	MAX	MIN	MAX		
f_{clock}	Clock frequency (at 50% duty cycle)	0	17	0	30	MHz	
t_w	Pulse duration	CLK high or low		16.5		ns	
		$\overline{\text{CLR}}$ low		10			
t_{su}	Setup time before CLK \uparrow	S0 or S1		20		ns	
		Serial or parallel data	High		16		
			Low		6		
		$\overline{\text{CLR}}$		15			15
t_h	Hold time after CLK \uparrow	S0 or S1		0		ns	
		Serial or parallel data		0			

† Inactive-state setup time is also referred to as recovery time.

switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	$V_{\text{CC}} = 4.5 \text{ V to } 5.5 \text{ V}$, $C_L = 50 \text{ pF}$, $R_1 = 500 \Omega$, $R_2 = 500 \Omega$, $T_A = \text{MIN to MAX}^\ddagger$				UNIT
			SN54ALS299		SN74ALS299		
			MIN	MAX	MIN	MAX	
f_{max}			17		30	MHz	
t_{PLH}	CLK	$Q_A - Q_H$	2	19	4	13	ns
t_{PHL}			4	25	7	19	
t_{PLH}	CLK	$Q_{A'} - Q_{H'}$	2	21	5	15	ns
t_{PHL}			4	25	8	18	
t_{PHL}	$\overline{\text{CLR}}$	$Q_A - Q_H$	6	29	6	22	ns
		$Q_{A'} - Q_{H'}$	6	29	6	22	
t_{PZH}	$\overline{\text{OE1}}, \overline{\text{OE2}}$	$Q_A - Q_H$	5	22	6	16	ns
t_{PZL}			6	27	8	22	
t_{PZH}	S0, S1	$Q_A - Q_H$	5	27	7	17	ns
t_{PZL}			6	26	8	22	
t_{PHZ}	$\overline{\text{OE1}}, \overline{\text{OE2}}$	$Q_A - Q_H$	1	15	1	8	ns
t_{PLZ}			4	38	5	15	
t_{PHZ}	S0, S1	$Q_A - Q_H$	1	16	1	12	ns
t_{PLZ}			4	34	8	25	

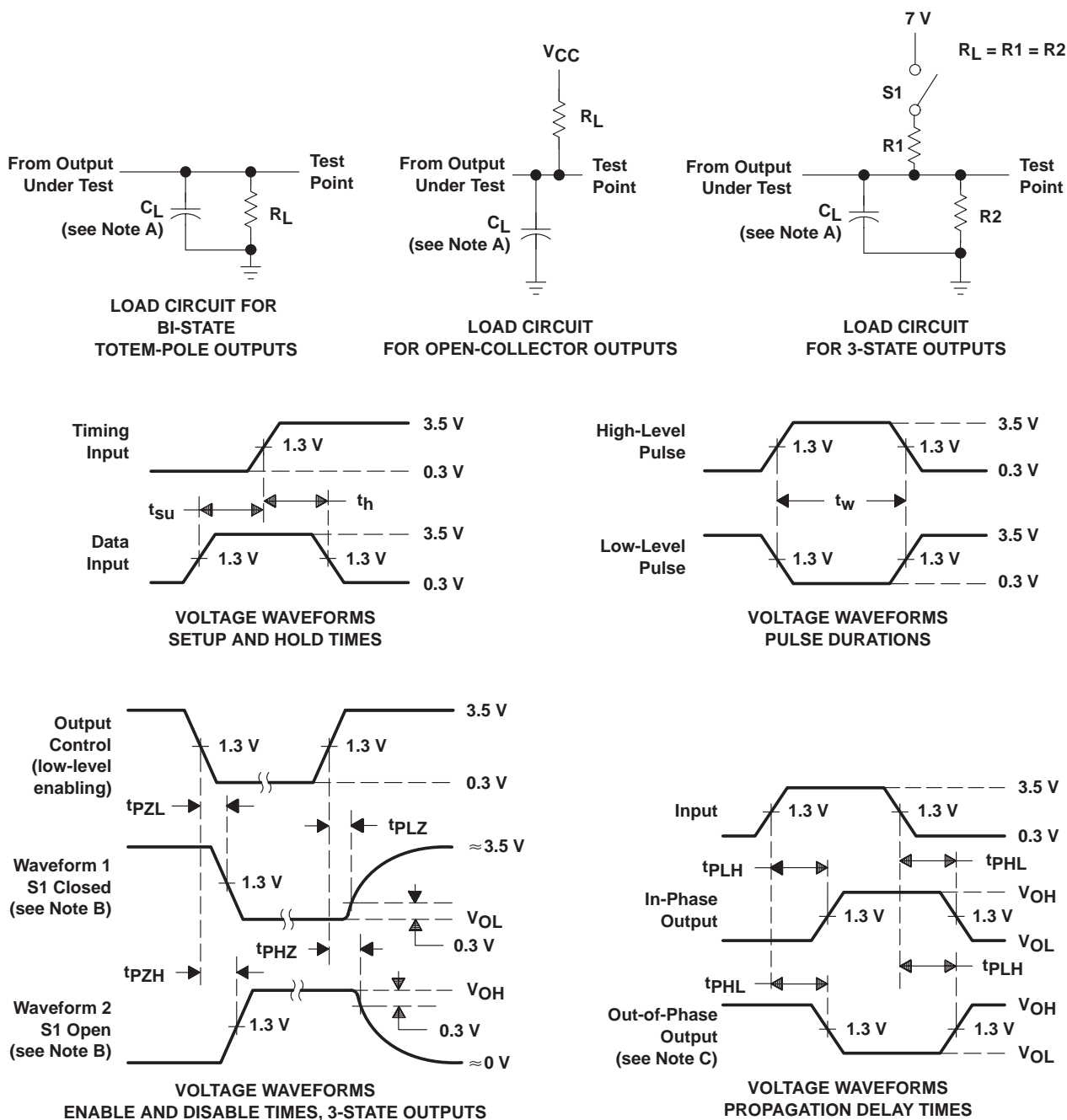
‡ For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.



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PARAMETER MEASUREMENT INFORMATION SERIES 54ALS/74ALS AND 54AS/74AS DEVICES



- NOTES: A. C_L includes probe and jig capacitance.
 B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
 C. When measuring propagation delay items of 3-state outputs, switch S1 is open.
 D. All input pulses have the following characteristics: $PRR \leq 1$ MHz, $t_r = t_f = 2$ ns, duty cycle = 50%.
 E. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuits and Voltage Waveforms

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